

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/687,528	STERN ET AL.	
Examiner	Art Unit	
Shin-Lin Chen	1632	

SEARCHED					
Class	Subclass	Date	Examiner		
Updated		9/8/2005	4		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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